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TRACKER 4000

The ultimate benchtop troubleshooting tool



The Huntron Tracker 4000 provides state-of-the-art troubleshooting methodology using analog signature analysis techniques. The dual trace CRT display quickly compares known good component signatures with the device under test, thus detecting subtle problems such as IC leakage, intermittent faults, open capacitors etc. All this and more without the need to power up the circuit under test and perhaps cause further damage.

The Tracker 4000 can supply any combination of more than 6000 selections of voltage, source resistance and test frequency. Up to 20 customized test groups can be stored internally with four ranges per group, so the best possible range of test parameters may be determined to produce the optimum display of the device's signature. Huntron's exclusive STAR (Safe Tracker Active Range) feature prevents damaging a component by setting test parameters beyond its current limitations.

An integral pulse generator allows the testing of gate fired devices such as SCRs and TRIACs.

Versatility of test

The range of test parameters available makes the Tracker 4000 capable of troubleshooting a wide range of components. Passive devices, surface mount, low voltage logic, CMOS, TTL, and mixed-signal technology boards are all within the Tracker 4000's capability.

Testing a circuit with differing combinations of voltage, resistance and frequency allows the user to effectively isolate components, essentially eliminating any parallel influences. For example if a capacitor is tested at 200mV, any shunt semiconductors will remain turned off and the capacitor will be tested as if out of the circuit. Testing at a higher voltage and lower frequency will eliminate the effects of the capacitor and display the signature of the parallel device.

Ordering Information

The Huntron Tracker 4000 comes complete with Huntron MP20 Microprobes (one pair), common test leads, two mini-clip leads, power cord and instruction manual.

- State-of-the-art troubleshooting using variable ranges
- Dual trace CRT quickly compares component signatures
- Huntron's exclusive STAR feature prevents component damage by not allowing voltage-resistance combinations that exceed an IC's current specifications

SPECIFICATIONS

Sine wave

Waveform

Test Frequencies	
40 selections of frequen	
	20Hz to 190Hz in 10Hz
	steps, 200Hz to 1.9kHz in
	100Hz steps, 2kHz to
	5kHz in 1kHz steps
Open circuit Voltage (V _s):	
24 selections of peak vo	
	200mV, 400mV, 600mV, 800mV, 1V to 20V in 1V
	steps, including
	10V (Low), 15V (M1),
	20V (M2)
Source Resistance (R _s):	, ,
13 selections of resistan	ce:
	10Ω , 20Ω , 50Ω , 100Ω ,
	200Ω, $500Ω$, $1kΩ$,
	$2k\Omega$, $5k\Omega$, $10k\Omega$, $20k\Omega$,
	50kΩ, 100 kΩ, plus
	54Ω (Low), $1.2k\Omega$ (M1),
Cl 1 -	26.7kΩ (M2)
Channels Number	2
Display modes	A, B, Alt, A+B
Protection	Electronic circuit breaker
Pulse Generator	Zieenome eneum oreaner
Level	0 to ±10V
Width (Pulse mode)	2% to 50% duty cycle
Source Resistance	100Ω
Maximum Current	100mA
Displays	
CRT	mono 2.8 in (7 cm) diag
LCD	graphic, 128 x 64 pixels
Power Requirements	
Line Voltage	90VAC to 250VAC
Frequency	47Hz to 63Hz
Power	45 Watts
Dimensions	11.6in W x 4.5in H x
	15in D
	(30cm W x 11.5cm H x 38cm D)
Weight	10lbs (4.5kg)
Weight Operating Temp	32°F to +104°F
Operating rellip	(0°C to +40°C)
Storage Temp	-4°F to +140°F
Storage Temp	(-20°C to +60°C)
Warranty	1 year, limited
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